

EN 55014-1:2006+A1:2009+A2:2011, EN 55014-2:2015 EN 61000-3-2:2014, EN 61000-3-3:2013

EMC MEASUREMENT AND TEST REPORT FOR

Client: TAIZHOU XINWILO ELECTRIC MOTOR CO.,LTD.

Address: Nianmuyang, Daxi Town, Wenling City, Zhejiang Province, China

Manufacturer: TAIZHOU WESTONE MACHINERY & ELECTRIC CO.,LTD. Address: Shangma industrial zone, Economic development area, Wenling, Zhejiang, China

MODEL: WRS15/4-130, WRS15/6-130, WRS20/4-130, WRS20/6-130,

WRS25/4-130,

WRS25/4-180, WRS25/6-130, WRS25/6-180, WRS25/8-180,

WRS32/4-180,

WRS32/6-180, WRS32/8-180, WRS15/4 EAC, WRS15/6

EAC, WRS20/4 EAC,

WRS20/6 EAC, WRS25/4 EAC, WRS25/6 EAC, WRS32/4 EAC, WRS32/6 EAC, WRS15/9-Z, WRS15/11-Z, WRS20/13, WRS20/15, W15G-10, W15G-15, W15G-18, W15GR-10,

W15GR-15, W15GR-18,

WRS40-370-F, WRS40-550-F, WRS40-750-F, WRS50-750-F,

WRS40-1100-F, WRS50-1100-F, WRS40-1500-F, WRS50-

1500-F

Aug. 13, 2015

This Report Concerns: **Equipment Type:** Original Report Water Pump

Test Engineer: Hu yachuang

Test Date: Jul.18, 2015 – Aug. 9, 2015

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GENERAL INFORMATION

Product Description for Equipment Under Test (EUT)

The product that is produced by **Taizhou WESTONE Machinery & Electric Co.,Ltd.** The Application WRS25/4-180 or the "EUT" as referred to in this report is: **Water Pump.**

WRS15/4-130, WRS15/6-130, WRS20/4-130, WRS20/6-130, WRS25/4-130, WRS25/4-180, WRS25/6-130, WRS25/6-180, WRS32/6-180, WRS32/6-180, WRS32/8-180, WRS15/4 EAC, WRS15/6 EAC, WRS20/4 EAC, WRS20/6 EAC, WRS25/4 EAC, WRS25/6 EAC, WRS32/4 EAC, WRS32/6 EAC, WRS15/11-Z, WRS20/13, WRS20/15, W15G-10, W15G-15, W15G-18, W15GR-10, W15GR-15, W15GR-18.

WRS40-370-F, WRS40-550-F, WRS40-750-F, WRS50-750-F.

WRS40-1100-F, WRS50-1100-F, WRS40-1500-F, WRS50-1500-F are family products and same in the circuit and the structure.

Objective

In order to meet the EMC requirements approved by CENELEC, the following standards will be cited:

- 1. EN 61000-3-2:2014, EMC-Limits-Limits for the harmonic current emissions (equipment input current up to and including 16 A per phase).
- 2. EN 61000-3-3:2013 ,EMC-Limits-Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current \leq 16 A per phase and not subject to conditional connection.
- 3. EN 55014-1:2006+A1:2009+A2:2011, Electromagnetic compatibility-Requirements for household appliances, electric tools and similar apparatus Emission.
- 4. EN 55014-2:2015, Electromagnetic compatibility-Requirement for household appliances, electric tools and similar apparatus Immunity Product family standard.

The following satandares were also be cited in: EN61000-4-2:2009, EN61000-4-4:2012, EN61000-4-5:2006, EN61000-4-6:2014, EN61000-4-11:2004

Note: The test data is only valid for the test sample. There is possible deviation from the original test data for other products

Equipment Modifications

No modification to the EUT were made by China Ceprei (Sichuan) Laboratory to make sure the EUT comply with applicable limits.

1-EN61000-3-2

1.1 Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Last Cal. Date	Cal. Period
EMC- PARTNER	Harmonics and Flicker Analyzer	HARMONIC S-1000	HAR1000-40	2014.7	3 Year

^{*}Statement of Traceability: China Ceprei (Sichuan) Laboratory certifies that all calibrations have been performed using suitable standards traceable to the CHINA SCEIENTIFIC MEASUREMENT INSTITUTE.

1.2 Description of Measurement Conditions

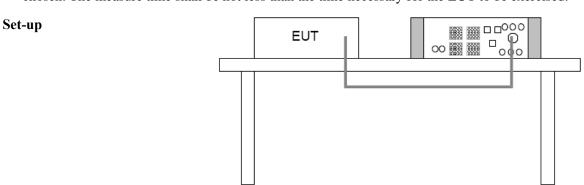
Temperature: 21°C Humidity: 58% Pressure: 1033mbar

Electromagnetic environment: normal

1.3 Test procedure and the test set-up

Procedure

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- b. The classification of EUT is according to section 5 of EN 61000-3-2. The EUT is classified as follows:
 - Class A: Balanced three-phase equipment, Household appliances excluding equipment as Class D, Tools excluding portable tools, Dimmers for incandescent lamps, audio equipment, equipment not specified in one of the three other classes.
 - Class B: Portable tools. Arc welding equipment which is not professional equipment
 - Class C: Lighting equipment, including dimming devices.
 - Class D: Equipment having a specified power less than or equal to 600 W of the following types: Personal computers and personal computer monitors.
- c. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.



1.4 Test Data and Records

WRS25/4-180						
0.1	т.	т		T	Q	
Order	Freq.	Iavg	Imax	Limit	Status	
1	[Hz] 50	[A] 1.6895	[A] 1.8439	[A]		
1 2 3 4 5	100	0.0122	0.0128	1.0800		
3	150	0.1062	0.1117	2.3000		
<i>A</i>	200	0.0000	0.0018	0.4300		
5	250	0.0244	0.0244	1.1400		
6	300	0.0000	0.0006	0.3000		
6 7	350	0.0110	0.0116	0.7700		
8	400	0.0000	0.0000	0.2300		
9	450	0.0000	0.0085	0.4000		
10	500	0.0000	0.0000	0.1840		
11	550	0.0000	0.0067	0.3300		
12	600	0.0000	0.0000	0.1533		
13	650	0.0000	0.0049	0.2100		
14	700	0.0000	0.0000	0.1314		
15	750	0.0000	0.0037	0.1500		
16	800	0.0000	0.0000	0.1150		
17	850	0.0000	0.0037	0.1324		
18	900	0.0000	0.0000	0.1022		
19	950	0.0000	0.0037	0.1184		
20	1000	0.0000	0.0000	0.0920		
21	1050	0.0000	0.0024	0.1071		
22	1100	0.0000	0.0000	0.0836		
23	1150	0.0000	0.0018	0.0978		
24	1200	0.0000	0.0000	0.0767		
25	1250	0.0000	0.0018	0.0900		
26	1300	0.0000	0.0000	0.0708		
27	1350	0.0000	0.0018	0.0833		
28	1400	0.0000	0.0000	0.0657		
29	1450	0.0000	0.0018	0.0776		
30	1500	0.0000	0.0000	0.0613		
31	1550	0.0000	0.0012	0.0726		
32 33	1600	0.0000	0.0000	0.0575		
33 34	1650 1700	$0.0000 \\ 0.0000$	0.0012 0.0000	0.0682 0.0541		
35	1750	0.0000	0.0000	0.0541		
36	1800	0.0000	0.0012	0.0511		
37	1850	0.0000	0.0012	0.0608		
38	1900	0.0000	0.0012	0.0484		
39	1950	0.0000	0.0006	0.0577		
40	2000	0.0000	0.0000	0.0460		
Result: PA		0.0000	0.0000	0.0100		

1.5 Verdict

The EUT met the requirement.

2 -EN61000-3-3

2.1 Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Last Cal. Date	Cal. Period
EMC- PARTNER	Harmonics and Flicker Analyzer	HARMONIC S-1000	HAR1000-40	2013.7	3 Year

^{*}Statement of Traceability: China Ceprei (Sichuan) Laboratory certifies that all calibrations have been performed using suitable standards traceable to the CHINA SCEIENTIFIC MEASUREMENT INSTITUTE.

2.2 Description of Measurement Conditions

Temperature: 21°C Humidity: 58% Pressure: 1033mbar

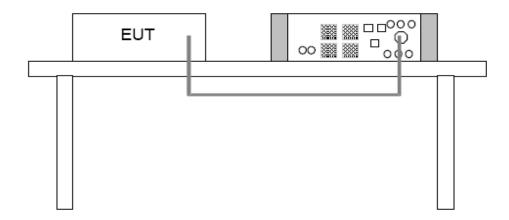
Electromagnetic environment: normal

2.3 Test procedure and the test set-up

Procedure

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.
- b. During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

Set-up



2.4 Test Data and Records

Plt = 0.072	Plt = 0.072				
	Pst	dmax	dc	dt>Lim	
1	0.072	0.000	0.120	0.000	
2	0.073	0.410	0.230	0.000	
3	0.072	0.470	0.290	0.000	
4	0.072	0.000	0.210	0.000	
5	0.073	0.000	0.190	0.000	
6	0.072	0.430	0.270	0.000	
7	0.072	0.000	0.150	0.000	
8	0.072	0.440	0.390	0.000	
9	0.072	0.000	0.160	0.000	
10	0.072	0.400	0.180	0.000	
11	0.072	0.000	0.000	0.000	
12	0.072	0.410	0.420	0.000	
Result: PA	SSED				

2.5 Verdict

The EUT met the requirement.

3-EN55014-1

3.1 Continuous Disturbance Voltage at Mains Terminal.

3.1.1 Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Last Cal. Date	Cal. Period
Albatross Projects GmbH	Shield Room	Site 1		2013.10	2 Year
R&S	EMI Test Receiver	ESU40	1302	2014.11	1 Year
R&S	Artificial Mains (Two Line)	ENV216	3560	2014.2	2 Year
R&S	EMI Test System Cabinet			N/A	N/A
R&S	EMI Test Software	EMC32		N/A	N/A

^{*}Statement of Traceability: China Ceprei (Sichuan) Laboratory certifies that all calibrations have been performed using suitable standards traceable to the CHINA SCEIENTIFIC MEASUREMENT INSTITUTE.

3.1.2 Description of Measurement Conditions

Temperature: 21°C Humidity: 58% Pressure: 1033mbar

Electromagnetic environment: normal

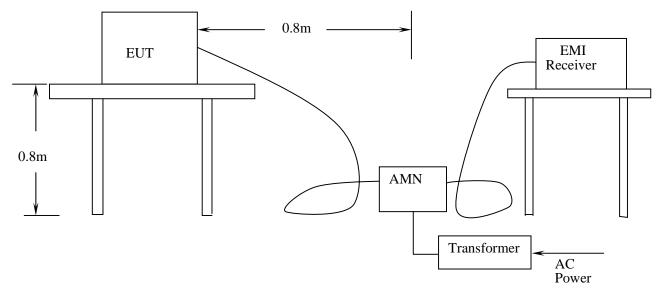
3.1.3 Limits of Continuous Disturbance Voltage at Mains Terminal.

requency range	Limit values dBμV		
MHz	Quasi-peak	Average	
0.15 to 0.50	66-56 ^a	59 to 46 ^a	
0.50 to 5	56	46	
5 to 30	60	50	
	0.15 to 0.50 0.50 to 5	Quasi-peak 0.15 to 0.50 66-56 a 0.50 to 5 56	

Note: If the limit for the measurement with the average detector is met when using a receiver with a quasi-peak detector, the equipment under test shall be deemed to meet both limits and the measurement using the receiver with an average detector need not be carried out.

3.1.4 Configuration

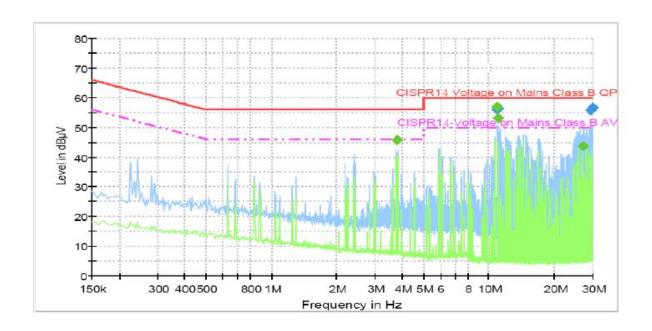
The configuration is in accordance with the requirement in EN55014-1, the sketch map as follow:



3.1.5 Test Data and Records

PASSED

L& N:



Disturbance Volt	age at the Mains T			
Frequency	Amplitude	Detector	Limit	
MHz	dBμV	QP/Ave/Peak	dBμV	
0.15-0.5	*	QP	66-56 Decreasing linearly with logarithm of the frequency	
0.50-5	*	QP	56	
5-30 * QP 60				
* Means the continuous disturbance voltage level 6 dB lower than limits.				

3.1.6 Verdict

The EUT met the requirement.

3.2.1 Disturbance Power

3.2.1 Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Last Cal. Date	Cal. Period
R&S	Absorbing Clamp	MDS-21	0194	2014.1	2 Year
R&S	EMI Test Receiver ESU40		1302	2014.11	1 Year
R&S	EMI Test System Cabinet			N/A	N/A
Albatross Projects GmbH	Shield Room	Site 1		2013.10	2 Year
R&S	EMI Test Software	EMC32		N/A	N/A

^{*}Statement of Traceability: China Ceprei (Sichuan) Laboratory certifies that all calibrations have been performed using suitable standards traceable to the CHINA SCEIENTIFIC MEASUREMENT INSTITUTE.

3.2.2 Description of Measurement Conditions

Temperature: 21 °C Humidity: 56% Pressure: 1033mbar

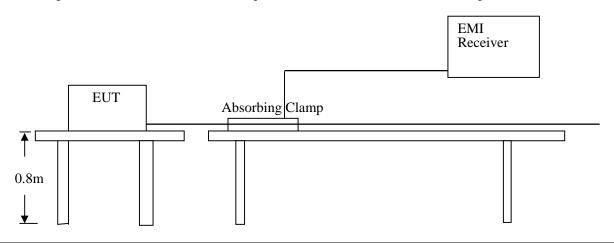
Electromagnetic environment: normal

3.3.3 Limits of Disturbance Power

Equipment type	Frequency range	Limit values (dBpW)			
Equipment type	MHz	Quasi-peak	Average		
Household appliance	30 to 300	45 to 55 ^a	35 to 45 ^a		
^a Increasing linearly with frequency.					

3.2.4 Configuration

The configuration in accordance with the requirement in EN55014-1, the sketch map as follow:

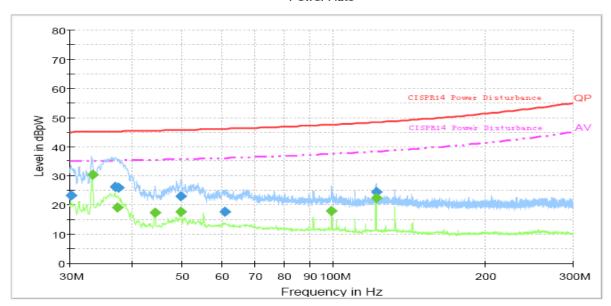


Report # SCC(15)-50108A-21-10-LVD

3.2.5 Test Data and Records

Passed

Power Auto



Disturbance Volt	age at the Mains To	erminal TEST DATA		
Frequency	Amplitude	Detector	Limit	
MHz	dBμV	QP/Ave/Peak	dBμV	
30 to 300	*	QP	45-55 Decreasing linearly with logarithm of the frequency	
* Means the continuous disturbance voltage level 6 dB lower than limits.				

3.2.6 Verdict

The EUT met the requirement.

3.3 Radiated disturbances

3.3.1 Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Last Cal. Date	Cal. Period
Albatross Projects GmbH	Semi-Anechoic Chamber		9290832	2014.10	2 Year
R&S	Ultra-broadband Antennas	HL562		2014.1	2 Year
Inn-co GmbH	Antenna Towers			N/A	N/A
R&S	EMI Test Receiver	ESU40	1302	2014.11	1 Year
Inn-co GmbH	Turntable	DS2000S-1t		N/A	N/A
Inn-co GmbH	Controller	CO 2000	10806L	N/A	N/A
R&S	EMI Test Software	EMC32		N/A	N/A
R&S	EMI Test System Cabinet			N/A	N/A

^{*}Statement of Traceability: China Ceprei (Sichuan) Laboratory certifies that all calibrations have been performed using suitable standards traceable to the CHINA SCEIENTIFIC MEASUREMENT INSTITUTE.

3.3.2 Test Procedure

The EUT was placed on a turn table. The turn table can rotate 360 degrees to determine the position of the maximum emission level. EUT was set 3 meter (Semi-Anechoic Chamber) away from the receiving antenna which was mounted on a antenna tower. The antenna can move up and down between 1 to 4 meters to find out the maximum emission level. Broadband antenna (calibrated biconical and log periodical antenna) were used as a receiving antenna. Both horizontal and vertical polarization of the antenna were set on measurement.

The bandwidth of the R&S EMI Receiver ESU40 was set at 120 kHz.

The frequency range from 30MHz to 1000MHz was pre-scanned with a peak detector.

The all final readings from test receiver were measured with Quasi-Peak detector.

3.3.3 Radiated Emission Limit

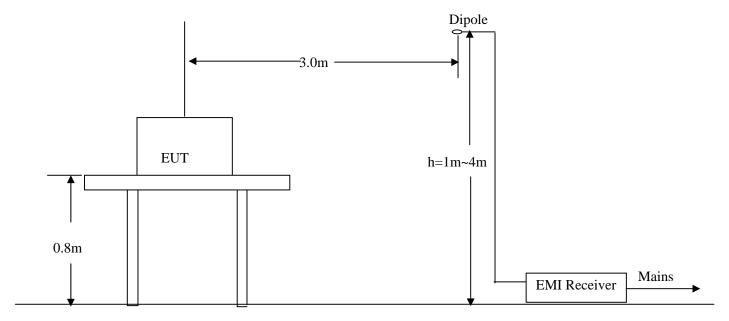
FREQUENCY (MHz)	DISTANCE (m)	FIELD STRENGTHS LIMITS (dBu V/m)
30-230	10(3)	30(40)
230-1000	10(3)	37(47)

Note: (1) The lower limit shall apply at the transition frequency.

(2) () is 3 meters limit.

3.3.4 Configuration

The configuration is in accordance with the requirement in EN55014, the sketch map as follow:

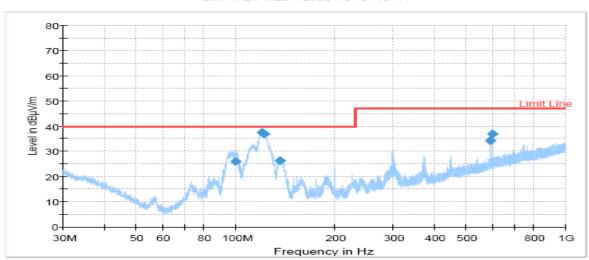


3.3.5 Test Data and Records

Passed

.

EMI RADIATED HL562 AUTO NOPA



Horizontal

Disturbance Volt	age at the Mains T									
Frequency	Amplitude	Limit								
MHz	dBμV	QP/Ave/Peak	dBμV							
30 to 230	*	QP	40							
230 to 1000 * QP 47										
* Means the contin	* Means the continuous disturbance voltage level 6 dB lower than limits.									

3.3.6 Verdict

The EUT met the requirement.

3.4 Discontinuous Disturbance Voltage at Mains Terminal (Click)

3.4.1 Test Equipment List and Details

0.00 - 0 000 00000 -					
Manufacturer	Description	Model	Serial Number	Last Cal. Date	Cal. Period
Albatross Projects GmbH	Shield Room	Site 1		2014.10	2 Year
AFJ	Click Meter	CL55C	5040019044	2014.11	1 Year
AFJ	Artificial Mains (Two Line)	LS16C	16010020077	2014.2	2 Year

^{*}Statement of Traceability: China Ceprei (Sichuan) Laboratory certifies that all calibrations have been performed using suitable standards traceable to the CHINA SCEIENTIFIC MEASUREMENT INSTITUTE.

3.4.2 Description of Measurement Conditions

Temperature: 22°C Humidity: 56% Pressure: 1033mbar

Electromagnetic environment: normal

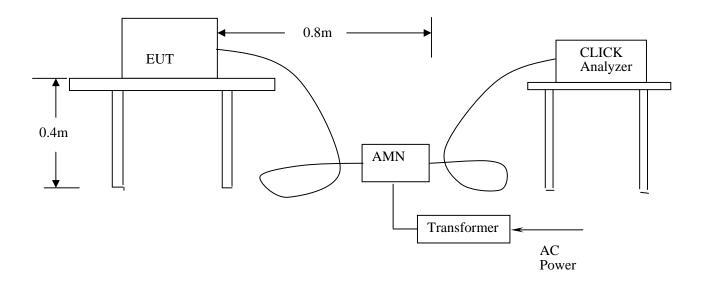
3.4.3 Limits of Click

For discontinuous disturbance, the click limit is attained by increasing the relevant limit of Continuous Disturbance Voltage with:

N < 0.2 or for 20lg(30/N) dB for $0.2 \le N < 30$

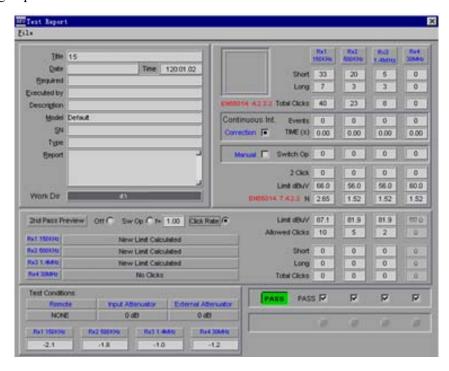
3.4.4 Configuration

The configuration in accordance with the requirement in EN55014-1, the sketch map as follow:



3.4.5 Test Data and Records

Click Photograhp



3.4.6 Verdict

The EUT met the requirement.

4-EN55014-2

Description of Performance Criterion (According with EN55014-2 Section 6)

Performance Criterion A

The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. If the minimum performance level or the permissible performance loss is not specified by the manufacture, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.

Performance Criterion B

The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however, no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacture, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.

Performance Criterion C

Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.

4.1 SURGES

4.1.1 Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Last Cal. Date	Cal. Period
Noise Laboratory CO., LTD	Surge Lite	LSS-6030	9099E00350	2014.11	2 Year

^{*}Statement of Traceability: China Ceprei (Sichuan) Laboratory certifies that all calibrations have been performed using suitable standards traceable to the CHINA SCEIENTIFIC MEASUREMENT INSTITUTE.

4.1.2 Description of Measurement Conditions

Temperature: 21°C Humidity: 58% Pressure: 1033mbar

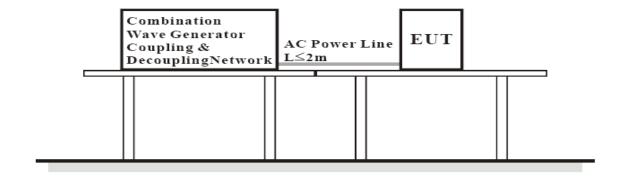
Electromagnetic environment: normal

4.1.3 Test procedure and the test set-up

Procedure

- a. For EUT power supply:
 - The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).
- b. For test applied to unshielded unsymmetrically operated interconnection lines of EUT: The surge is applied to the lines via the capacitive coupling. The coupling / decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).
- c. For test applied to unshielded symmetrically operated interconnection / telecommunication lines of EUT: The surge is applied to the lines via gas arrestors coupling. Test levels below the ignition point of the coupling arrestor cannot be specified. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

Set-up



4.1.4 Test Data and Records

Terminal	Voltage KV	Path	Phase Number Of Impulses		Pass	Fail
MAINS	±1	L-N	0°	5	В	
MAINS	±1	L-N	90°	5	В	
MAINS	±1	L-N	180°	5	В	
MAINS	±1	L-N	270°	5	В	

4.1.5 Verdict

The EUT was working as normal, so they met the requirement of performance criteria B.

4.2 ESD

4.2.1 Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Last Cal. Date	Cal. Period
Shanghai Sanki	Electrostatic Discharge tester	ESD-320	0329501C	2014.6	2 Year

^{*}Statement of Traceability: China Ceprei (Sichuan) Laboratory certifies that all calibrations have been performed using suitable standards traceable to the CHINA SCEIENTIFIC MEASUREMENT INSTITUTE.

4.2.2 Description of Measurement Conditions

Temperature: 21°C Humidity: 58% Pressure: 1033mbar

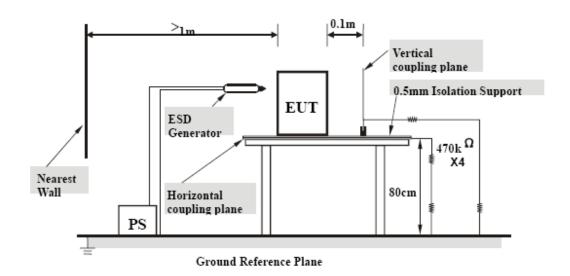
Electromagnetic environment: normal

4.2.3 Test procedure and the test set-up

Procedure

- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the EUT.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- g. At least ten single discharges (in the most sensitive polarity) were applied at the front edge of each Horizontal Coupling Plane opposite the center point of each unit of the EUT and 0.1 meters from the front of the EUT. The long axis of the discharge electrode was in the plane of the HCP and perpendicular to its front edge during the discharge.
- h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane in sufficiently different positions that the four faces of the EUT were completely illuminated. The VCP (dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the EUT.

Set-up



4.2.4 Test Data and Records

Air Discharge

	Test Levels															
EN61000-4-2 Test Points	-2 kV	+2 kV	-4 kV	+4 kV	-6 kV	+6 kV	-8 kV	+8 kV	-10 kV	+10 kV	-12.5 kV	+12.5 kV	-15 kV	+15 kV	-20 kV	+20 kV
EUT Front Side	В	В	В	В	В	В	В	В								
EUT Top Side	В	В	В	В	В	В	В	В								
EUT Back Side	В	В	В	В	В	В	В	В								
EUT Left Side	В	В	В	В	В	В	В	В								
EUT Right Side	В	В	В	В	В	В	В	В								

Direct Contact

	Test Levels															
EN61000-4-2 Test Points	-2 kV	+2 kV	-4 kV	+4 kV	-6 kV	+6 kV	-8 kV	+8 kV	-10 kV	+10 kV	-12.5 kV	+12.5 kV	-15 kV	+15 kV	-20 kV	+20 kV
EUT Front Side	В	В	В	В												
EUT Top Side	В	В	В	В												
EUT Back Side	В	В	В	В												
EUT Left Side	В	В	В	В												
EUT Right Side	В	В	В	В												

4.2.5 Verdict

The EUT was working as normal, so they met the requirement of performance criteria B.

4.3 EFT/B

4.3.1 Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Last Cal. Date	Cal. Period
Shanghai Sanki	E.F.TB Generator	8014	069504E	2014.6	2 Year

^{*}Statement of Traceability: China Ceprei (Sichuan) Laboratory certifies that all calibrations have been performed using suitable standards traceable to the CHINA SCEIENTIFIC MEASUREMENT INSTITUTE.

4.3.2 Description of Measurement Conditions

Temperature: 21°C Humidity: 58% Pressure: 1033mbar

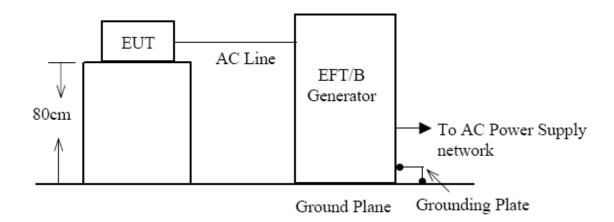
Electromagnetic environment: normal

4.3.3 Test procedure and the test set-up

Procedure

- a. Both positive and negative polarity discharges were applied.b. The length of the "hot wire" from the coaxial output of the EFT generator to the terminals on the EUT should not exceed 1 meter.
- c. The duration time of each test sequential was 1 minute.
- d. The transient/burst waveform was in accordance with IEC 61000-4-4, 5/50ns.

Set-up



4.3.4 Test Data and Records

The EUT was tested that it worked at the normal state.

Test Levels (kV)										
EN61000-4-	4 Test Points	+0.25	-0.25	+0.5	-0.5	+1.0	-1.0	+2.0	-2.0	
	L	В	В	В	В	В	В			
Power Port	N	В	В	В	В	В	В			
of EUT	L+ N	В	В	В	В	В	В			
	L+ N+PE	В	В	В	В	В	В			

4.3.5 Verdict

The EUT was working as normal, so it met the requirement of performance criteria B.

•

4.4 INJECTED CURRENTS

4.4.1 Test Equipment List and Details

Manufacturer	Description	Model Serial Number		Last Cal. Date	Cal. Period
Giga-tronics	Synthesized RF Signal Generator	6061A	5130304	2014.2	2 Year
QF	Broadband Power Amplifier	QF3860		2014.2	2 Year
QF	Millivoltmeter	QF2281	92028	2014.2	2 Year

^{*}Statement of Traceability: China Ceprei (Sichuan) Laboratory certifies that all calibrations have been performed using suitable standards traceable to the CHINA SCEIENTIFIC MEASUREMENT INSTITUTE.

4.4.2 Description of Measurement Conditions

Temperature: 22℃ Humidity: 59% Pressure: 1033mbar

Electromagnetic environment: normal

4.4.3 Configuration

The configuration in accordance with the requirement in EN61000-4-6, see the photo in appendix.

4.4.4 Test Data and Records

EN61000-4-6 Test Points	Frequency range MHz	Levels	Voltage Level (e.m.f.)V	Pass	Fail
Power Line	0.15-230MHz	1	1		
		2	3	A	
		3	10		
		X	Special		

4.4.5 Verdict

The apparatus continue to operate as intended during the test. No degradation of performance or loss of function. It is belong to Performance Criterion A so they met the requirement.

4.5 VOLTAGE DIPS AND INTERRUPTIONS

4.5.1 Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Last Cal. Date	Cal. Period
Noise Laboratory CO., LTD	Voltage Dip Simulator	VDS-220B	2199D00098	2014.10	2 Year

^{*}Statement of Traceability: China Ceprei (Sichuan) Laboratory certifies that all calibrations have been performed using suitable standards traceable to the CHINA SCEIENTIFIC MEASUREMENT INSTITUTE.

4.5.2 Description of Measurement Conditions

Temperature: 21°C Humidity: 58% Pressure: 1033mbar

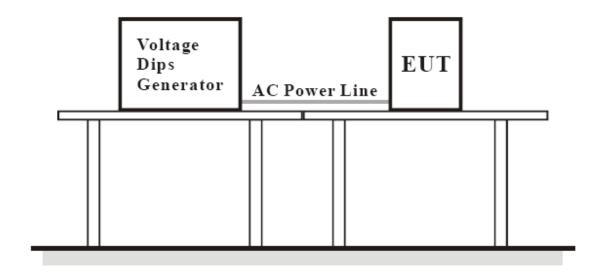
Electromagnetic environment: normal

4.5.3 Test procedure and the test set-up

Procedure

The EUT shall be tested for each selected combination of test levels and duration with a sequence of tree dips/interruptions with intervals of 10 s minimum (between each test event). Each representative mode of operation shall be tested. Abrupt changes in supply voltage shall occur at zero crossings of the voltage waveform.

Set-up



4.5.4 Test Data and Records

Environmer phenomer		Test level in % U _T	Duration (in periods of the rated frequency)	Phase Angle	Pass	Fail
Interruptions		0	0.5T	0/180	C	
Voltage dips	60	40	10T	0/180	С	
in % U_T	30	70	50T	0/180	C	

4.5.5 Verdict

The EUT was working as normal, so they met the requirement of performance criteria C.

4.6 Radio-frequency electromagnetic field

4.6.1 Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Last Cal. Date	Cal. Period
R&S	Signal Generator	SMR-40	1104	2014.11	1 Year
QF	Broadband Power Amplifier	QF3860		2014.2	2 Year
QF	Millivoltmeter	oltmeter QF2281 92028 2014.2		2014.2	2 Year
Albatross Projects GmbH	Anechoic Chamber		9290832	2014.10	2 Year
R&S	Ultra-broadband Antennas	HL562		2014.1	2 Year
Inn-co GmbH	Antenna Towers			N/A	N/A
Inn-co GmbH	Turntable DS2000S-1t			N/A	N/A
Inn-co GmbH	Controller	CO 2000	10806L	N/A	N/A

^{*}Statement of Traceability: China Ceprei (Sichuan) Laboratory certifies that all calibrations have been performed using suitable standards traceable to the CHINA SCEIENTIFIC MEASUREMENT INSTITUTE.

4.6.2 Description of Measurement Conditions

Temperature: 20°C Humidity: 60% Pressure: 1033mbar

Electromagnetic environment: normal

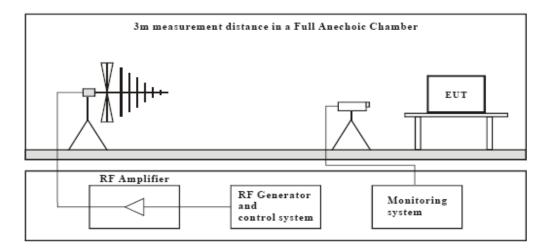
4.6.3 Test procedure and the test set-up

Procedure

The test procedure was in accordance with EN 61000-4-3

- a. The testing was performed in a fully-anechoic chamber. The transmit antenna was located at a distance of 3 meters from the EUT.
- b. The frequency range is swept from 80 MHz to 1000 MHz with the signal 80% amplitude modulated with a 1kHz sinewave. The rate of sweep did not exceed 1.5 x 10⁻³ decade/s. Where the frequency range is swept incrementally, the step size was 1 % of preceding frequency value.
- c. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- d. The field strength level was 3V/m.
- e. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

Set-up

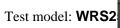


4.6.4 Test Data and Records

Frequency Range (MHz)	Front Side (3 V/m)		Rear Side (3 V/m)		Left Side (3 V/m)		Right Side (3 V/m)	
80-1000	VERT	HORI	VERT	HORI	VERT	HORI	VERT	HORI
	A	A	A	A	A	A	A	A

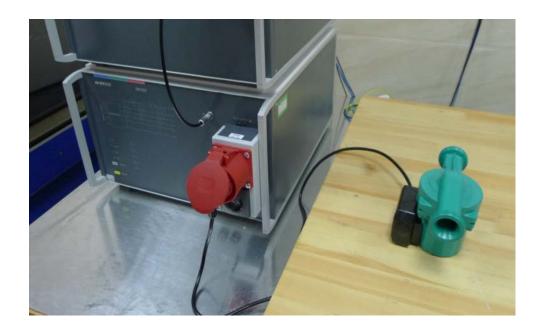
4.6.5 Verdict

The EUT was working as normal, so it met the requirement of performance criteria A.







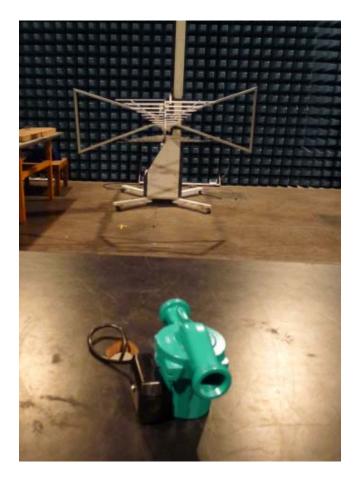












EC Declaration of conformity

Council Directive 2014/30/EU on Electromagnetic Compatibility

Client: TAIZHOU XINWILO ELECTRIC MOTOR CO.,LTD.
Address: NIANMUYANG, DAXI TOWN, WENLING CITY, ZHEJIANG PROVINCE, CHINA

Manufacturer: TAIZHOU WESTONE MACHINERY & ELECTRIC CO.,LTD. Address: SHANGMA INDUSTRIAL ZONE, ECONOMIC DEVELOPMENT AREA, WENLING, ZHEJIANG, CHINA

Certify that the product described is in conformity with the Directive 2014/30/EU as amended

Product Name: Water Pump

MODEL: WRS15/4-130, WRS15/6-130, WRS20/4-130, WRS20/6-130, WRS25/4-130, WRS25/4-180, WRS25/6-130, WRS25/6-180, WRS25/8-180, WRS32/4-180, WRS32/6-180, WRS32/8-180, WRS15/4 EAC, WRS15/6 EAC, WRS20/4 EAC, WRS20/6 EAC, WRS25/4 EAC, WRS25/6 EAC, WRS32/4 EAC, WRS32/6 EAC, WRS15/9-Z, WRS15/11-Z, WRS20/13, WRS20/15, W15G-10, W15G-15, W15G-18, W15GR-10, W15GR-15, W15GR-18, WRS40-370-F, WRS40-550-F, WRS40-750-F, WRS50-1500-F

The product has been assessed by the application of the following standards:

EN 55014-1:2006+A1:2009+A2:2011, EN 55014-2:2015 EN 61000-3-2:2014, EN 61000-3-3:2013

Issue place and date Company stamp and Signature of authorized personnel

Notice

1. This test report shall be invalid without the cachet of the testing laboratory.

2. This copied report shall be invalid without the sealed cachet of the testing

laboratory.

3. This report shall be invalid without tester signature, reviewer signature and

approver signature.

4. This report is invalid if altered.

5. Client shall put forward demurrer within 15days after receipt of report. The

testing laboratory shall refuse disposal if exceeded the time limit.

6. The test results presented in this report relate only to the object tested.

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